

Notice of References Cited	Application/Control No. 10/670,356	Applicant(s)/Patent Under Reexamination HATANO ET AL.	
	Examiner Tuan H. Nguyen	Art Unit 2813	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,635,554	10-2003	Im et al.	438/482
	B	US-6,440,824	08-2002	Hayashi et al.	438/486
	C	US-5,815,494	09-1998	Yamazaki et al.	372/25
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	P					
	Q					
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NON-PATENT DOCUMENTS

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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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